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**FACSIMILE****Date:** September 28, 2006**Time Sent:**

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<b>Sent By:</b>	Colette Goba, Paralegal Notice of Allowance Dept.	<b>Direct Phone:</b>	202.756.8680
<b>Client/Matter/Tkpr:</b>	61282-060	<b>Original to Follow by Mail:</b>	No
		<b>Number of Pages, Including Cover:</b>	15
<b>Re:</b>	U.S. Appln. No. 10/766,951 S. Takeoka, et al. "Method for Evaluating Delay Test Quality"		

**Message:**

Further to our conversation of September 27, 2006, we are pleased to transmit the Abstract of the Japanese reference in English, as well as a full machine translation. We look forward to receiving the initialed 1449 indicating you have considered the reference and entered it into the record. An additional PTO-1449 form is enclosed for your convenience.

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SHEET 1 OF 1

<b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b>  <b>(PTO-1449)</b>				ATTY. DOCKET NO. <b>61282-060</b>		SERIAL NO.	
				APPLICANT <b>Sadami TAKEOKA, et al.</b>			
				FILING DATE <b>January 30, 2004</b>		GROUP	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Codes (if any)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
		US 2003/0149918 A1	03/07/2003	Ohtake et al.			
		US 5,748,846	05/05/1998	Hosokawa			
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<b>FOREIGN PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes - Number - Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No
		09-268959	10/14/1997			X	
<b>OTHER ART (including author, title, date, pertinent pages, etc.)</b>							
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					
EXAMINER				DATE CONSIDERED			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.